Application/Control No. Applicant(s)/Patent Under Reexamination 10/708,838 BEENAU ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2876 Daniel I. Walsh **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2003/0004866 01-2003 705/38 Huennekens et al. Α US-2005/0102524 05-2005 Haala, Catherine A. 713/186 В 705/038 US-2005/0065872 03-2005 С Moebs et al. US-D US-Ε US-F US-G US-Н US-1 US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Classification Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S

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